

**Notic of References Cited**

Application/Control No.

09/955,632

Applicant(s)/Patent Under  
Reexamination  
PAREKH ET AL.

Examiner

Yennhu B Huynh

Art Unit

2813

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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X	B	US-5418180	05-1995	Brown	438/396
	C	US-5324679	06-1994	Kim et al.	438/386
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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